SHEET 1 OF 1

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE				ATTY DOCKET NO.		SERIAL N			
(Modified) PATENT AND TRADEMARK (			EMARK OFFICE	258047US40PCT		10/510,344			
			APPLICANT						
LIST OF	REFEF	RENCES CITED BY API	PLICANT	Kazushige OHNO	shige OHNO				
				FILING DATE		GROUP			
				April 14, 2005		1743			
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE			
/A.H./	AA	US 2006/0254231 A1	11/16/2006	Hayashi et al.					
1	AB	US 2007/0190350 A1	08/16/2007	Ohno et al.					
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	AD	US 2007/0068128 A1	03/29/2007	Oshimi et al.					
\/	ΑE	US 2007/0169453 A1	07/26/2007	Hayakawa					
<b>W</b>	AF	US 2007/0130897 A1	06/14/2007	Sakaguchi et al.					
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FOREIGN PATENT DOCUMENTS									
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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	AZ		- to account a		Additional References sheet(s) attached				
Examiner	Examiner /Amber Miller Harris/					Date Considered 04/10/2008			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									